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| <b>Notice of References Cited</b> | Application/Control No.<br>10/707,186 | Applicant(s)/Patent Under<br>Reexamination<br>LIDDY ET AL. |             |
|                                   | Examiner<br>Michael C. Maskulinski    | Art Unit<br>2113   | Page 1 of 2 |

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|   | M | US-  |                 |                    |                |

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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|                                   | Examiner<br>Michael C. Maskulinski    | Art Unit<br>2113   | Page 2 of 2 |

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